

IRLR8713PbF IRLU8713PbF

Applications

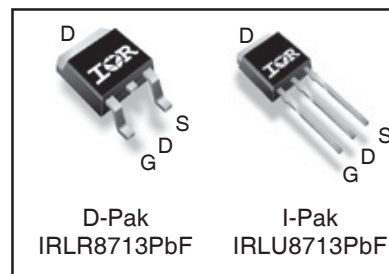
- High Frequency Synchronous Buck Converters for Computer Processor Power
- High Frequency Isolated DC-DC Converters with Synchronous Rectification for Telecom and Industrial Use

Benefits

- Very Low $R_{DS(on)}$ at 4.5V V_{GS}
- Ultra-Low Gate Impedance
- Fully Characterized Avalanche Voltage and Current
- Lead-Free

HEXFET® Power MOSFET

| V_{DSS} | $R_{DS(on)}$ max | Qg |
|-----------|------------------|--------|
| 25V | 4.8m Ω | 17.4nC |



| G | D | S |
|------|-------|--------|
| Gate | Drain | Source |

Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------------|---|-----------------------|---------------------|
| V_{DS} | Drain-to-Source Voltage | 25 | V |
| V_{GS} | Gate-to-Source Voltage | ± 20 | |
| $I_D @ T_C = 25^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10\text{V}$ | 100 ^④ | A |
| $I_D @ T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10\text{V}$ | 72 ^④ | |
| I_{DM} | Pulsed Drain Current ^① | 410 | |
| $P_D @ T_C = 25^\circ\text{C}$ | Maximum Power Dissipation ^⑤ | 81 | W |
| $P_D @ T_C = 100^\circ\text{C}$ | Maximum Power Dissipation ^⑤ | 40 | |
| | Linear Derating Factor | 0.54 | W/ $^\circ\text{C}$ |
| T_J | Operating Junction and | -55 to + 175 | $^\circ\text{C}$ |
| T_{STG} | Storage Temperature Range | | |
| | Soldering Temperature, for 10 seconds | 300 (1.6mm from case) | |

Thermal Resistance

| | Parameter | Typ. | Max. | Units |
|-----------------|---|------|------|---------------------------|
| $R_{\theta JC}$ | Junction-to-Case ^⑥ | — | 1.86 | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB Mount) ^{⑥⑥} | — | 50 | |
| $R_{\theta JA}$ | Junction-to-Ambient ^⑥ | — | 110 | |

Notes ^① through ^⑥ are on page 10

IRLR/U8713PbF

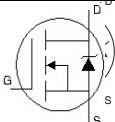
International
IR RectifierStatic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|--------------------------------|--------------------------------------|------|------|------|------------|--|
| BV_{DSS} | Drain-to-Source Breakdown Voltage | 25 | — | — | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| $\Delta BV_{DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | — | 16 | — | mV/°C | Reference to $25^\circ\text{C}, I_D = 1mA$ |
| $R_{DS(on)}$ | Static Drain-to-Source On-Resistance | — | 3.8 | 4.8 | m Ω | $V_{GS} = 10V, I_D = 21A$ ③ |
| | | — | 5.0 | 6.3 | | $V_{GS} = 4.5V, I_D = 17A$ ③ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 1.35 | 1.85 | 2.35 | V | $V_{DS} = V_{GS}, I_D = 50\mu A$ |
| $\Delta V_{GS(th)}/\Delta T_J$ | Gate Threshold Voltage Coefficient | — | -7.0 | — | mV/°C | |
| I_{DSS} | Drain-to-Source Leakage Current | — | — | 1.0 | μA | $V_{DS} = 20V, V_{GS} = 0V$ |
| | | — | — | 150 | | $V_{DS} = 20V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | $V_{GS} = 20V$ |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | $V_{GS} = -20V$ |
| g_{fs} | Forward Transconductance | 79 | — | — | S | $V_{DS} = 13V, I_D = 17A$ |
| Q_g | Total Gate Charge | — | 17.4 | 26 | nC | $V_{DS} = 13V$ $V_{GS} = 4.5V$ $I_D = 17A$ See Fig.16 |
| Q_{gs1} | Pre-Vth Gate-to-Source Charge | — | 4.0 | — | | |
| Q_{gs2} | Post-Vth Gate-to-Source Charge | — | 2.2 | — | | |
| Q_{gd} | Gate-to-Drain Charge | — | 5.8 | — | | |
| Q_{godr} | Gate Charge Overdrive | — | 5.4 | — | | |
| Q_{sw} | Switch Charge ($Q_{gs2} + Q_{gd}$) | — | 8.0 | — | nC | $V_{DS} = 10V, V_{GS} = 0V$ |
| Q_{oss} | Output Charge | — | 8.6 | — | | |
| R_G | Gate Resistance | — | 0.9 | 1.6 | Ω | |
| $t_{d(on)}$ | Turn-On Delay Time | — | 14 | — | ns | $V_{DD} = 13V, V_{GS} = 4.5V$ ③ $I_D = 17A$ Clamped Inductive Load |
| t_r | Rise Time | — | 24 | — | | |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 12 | — | | |
| t_f | Fall Time | — | 5.9 | — | | |
| C_{iss} | Input Capacitance | — | 2240 | — | pF | $V_{GS} = 0V$ $V_{DS} = 13V$ $f = 1.0MHz$ |
| C_{oss} | Output Capacitance | — | 580 | — | | |
| C_{rss} | Reverse Transfer Capacitance | — | 270 | — | | |

Avalanche Characteristics

| | Parameter | Typ. | Max. | Units |
|----------|---------------------------------|------|------|-------|
| E_{AS} | Single Pulse Avalanche Energy ② | — | 190 | mJ |
| I_{AR} | Avalanche Current ① | — | 17 | A |
| E_{AR} | Repetitive Avalanche Energy ① | — | 8.1 | mJ |

Diode Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|----------|---|--|------|-------|-------|--|
| I_S | Continuous Source Current (Body Diode) | — | — | 100 ④ | A | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I_{SM} | Pulsed Source Current (Body Diode) ① | — | — | 410 | | |
| V_{SD} | Diode Forward Voltage | — | — | 1.0 | V | $T_J = 25^\circ\text{C}, I_S = 17A, V_{GS} = 0V$ ③ |
| t_{rr} | Reverse Recovery Time | — | 16 | 24 | ns | $T_J = 25^\circ\text{C}, I_F = 17A, V_{DD} = 13V$ |
| Q_{rr} | Reverse Recovery Charge | — | 15 | 23 | nC | $di/dt = 300A/\mu s$ ③ |
| t_{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) | | | | |

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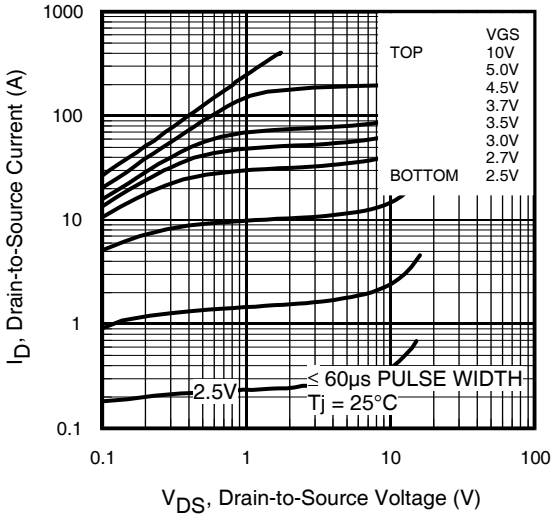


Fig 1. Typical Output Characteristics

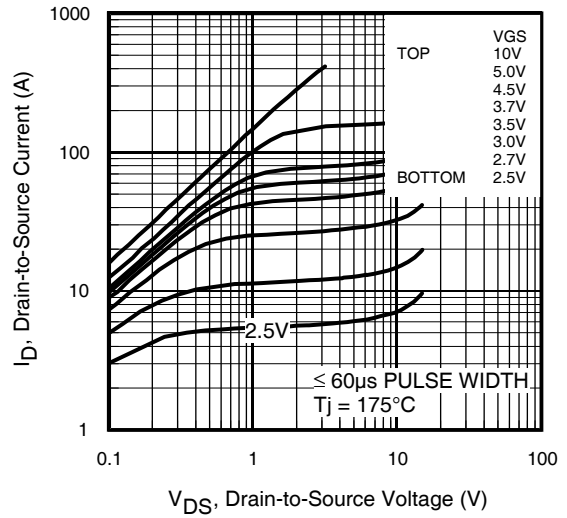


Fig 2. Typical Output Characteristics

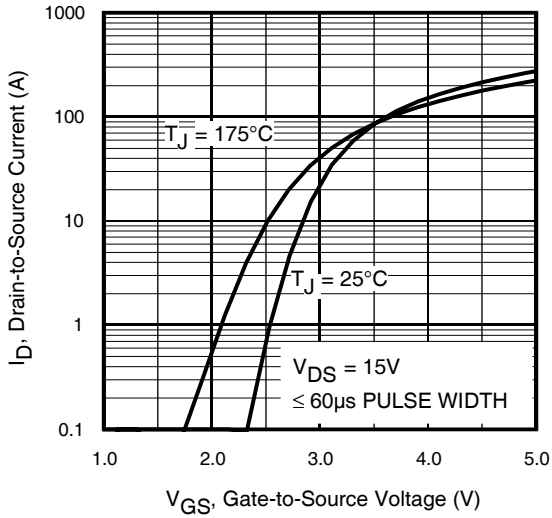


Fig 3. Typical Transfer Characteristics

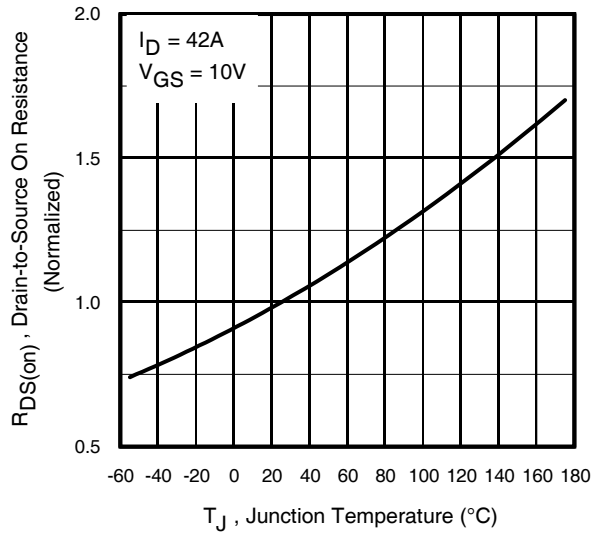


Fig 4. Normalized On-Resistance Vs. Temperature

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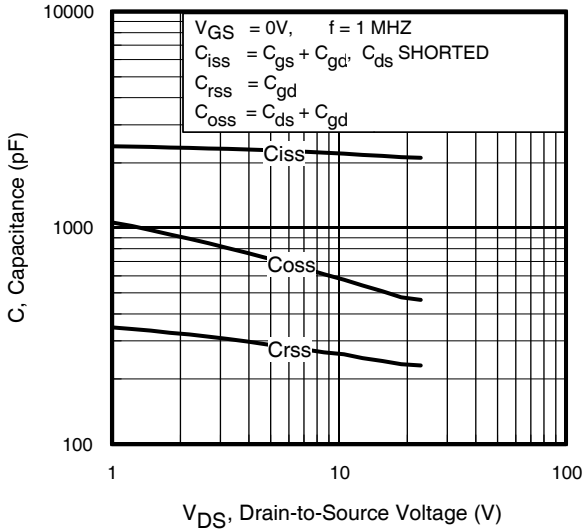


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

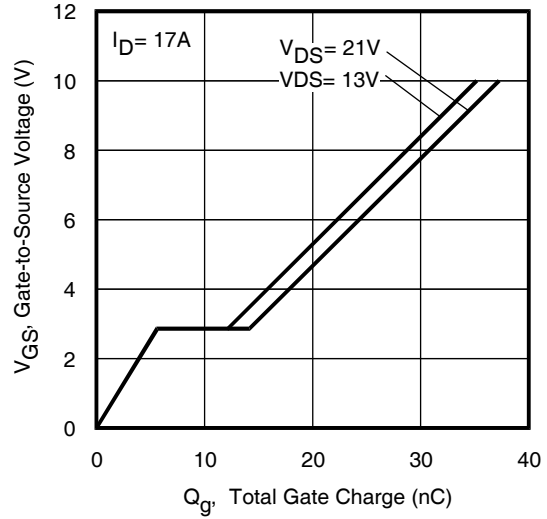


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

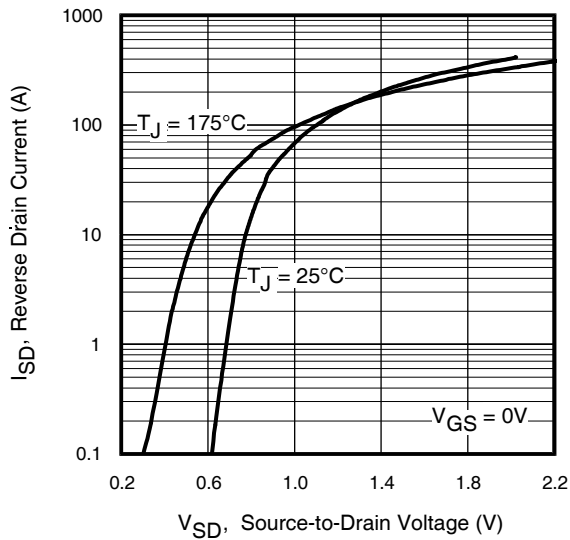


Fig 7. Typical Source-Drain Diode Forward Voltage

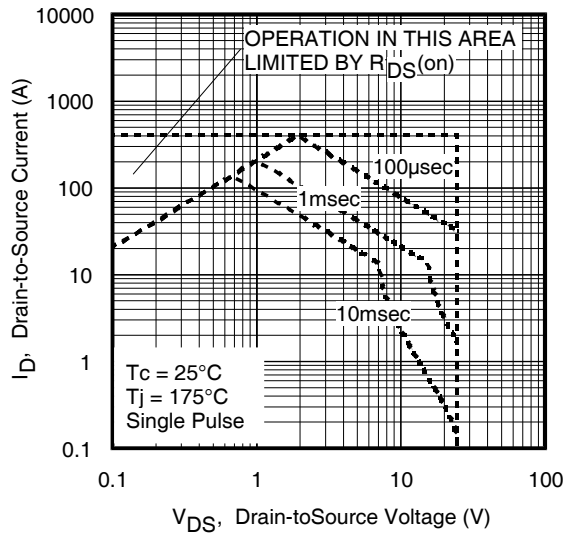


Fig 8. Maximum Safe Operating Area

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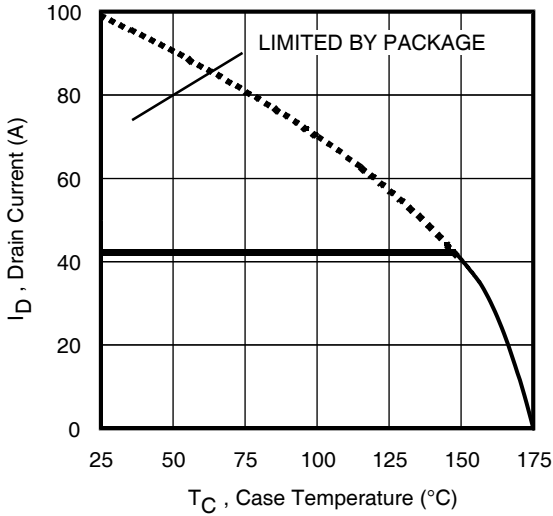


Fig 9. Maximum Drain Current Vs. Case Temperature

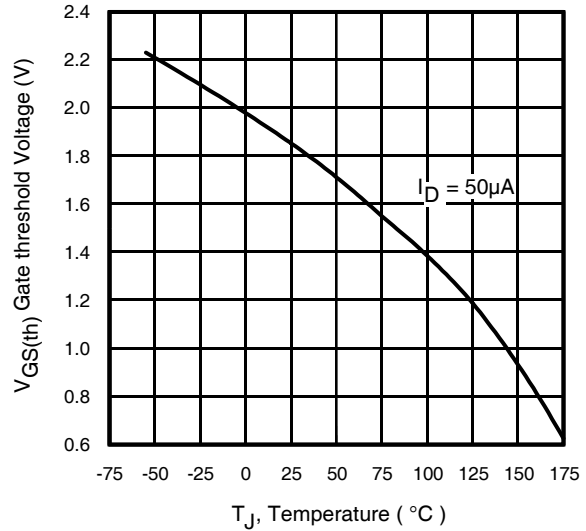


Fig 10. Threshold Voltage Vs. Temperature

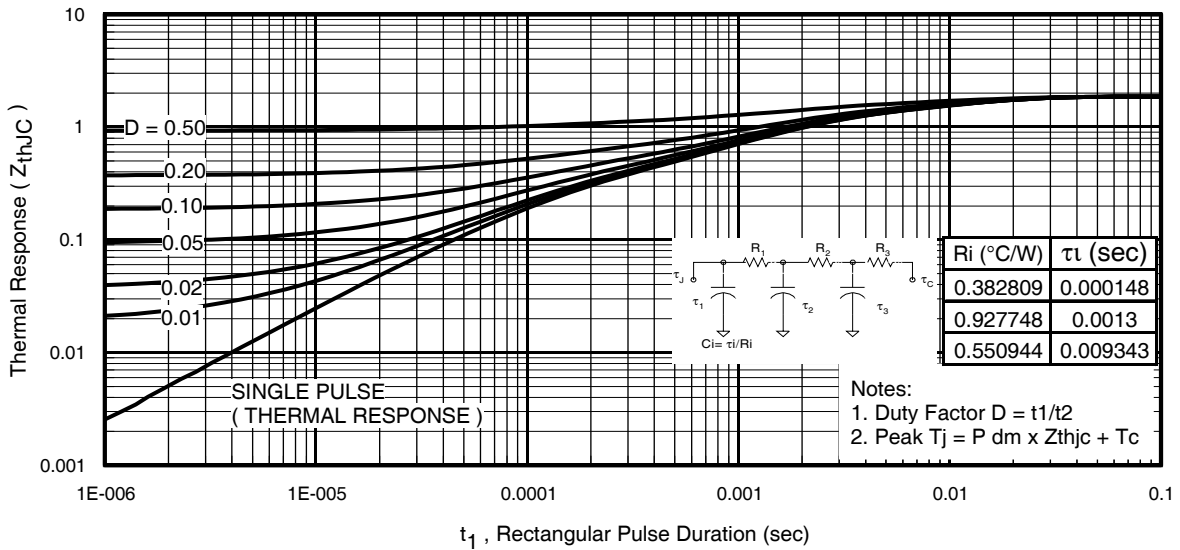


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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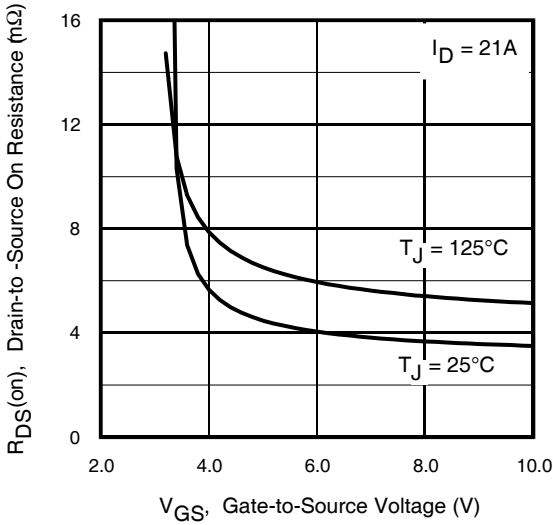


Fig 12. On-Resistance vs. Gate Voltage

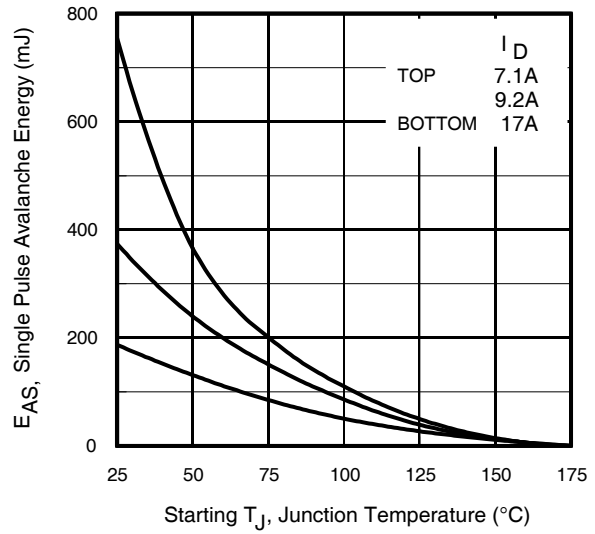


Fig 13. Maximum Avalanche Energy vs. Drain Current

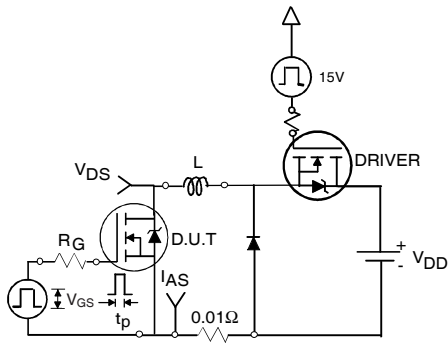


Fig 14a. Unclamped Inductive Test Circuit

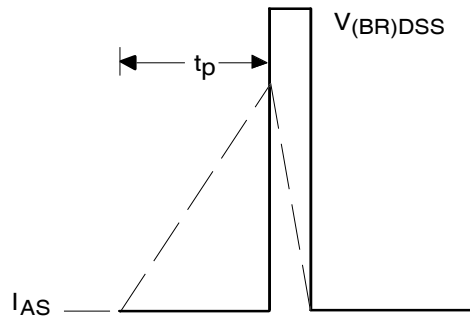


Fig 14b. Unclamped Inductive Waveforms

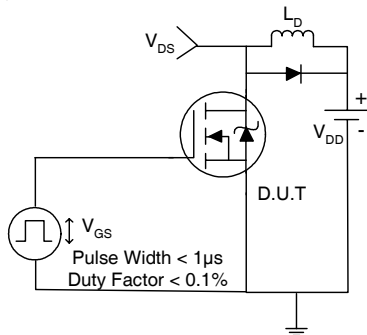


Fig 15a. Switching Time Test Circuit

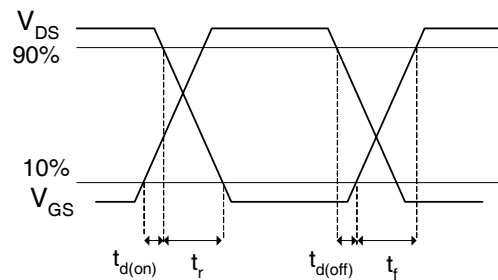


Fig 15b. Switching Time Waveforms

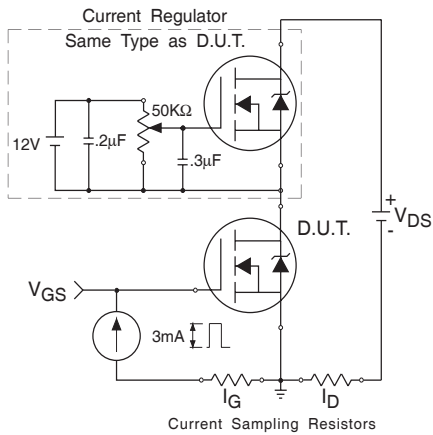


Fig 16a. Gate Charge Test Circuit

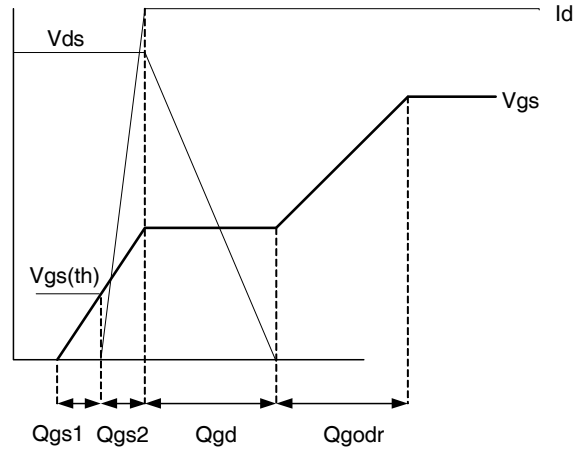
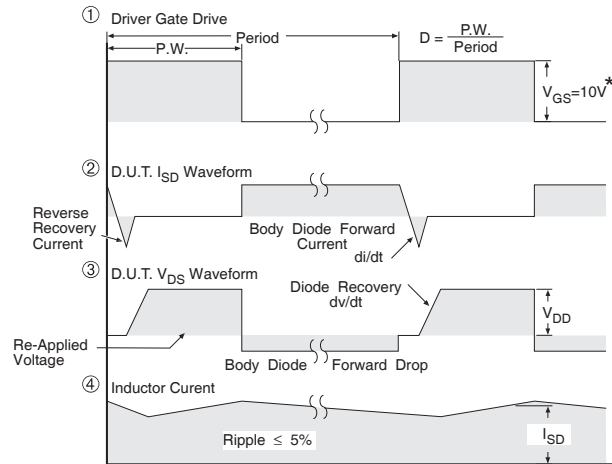
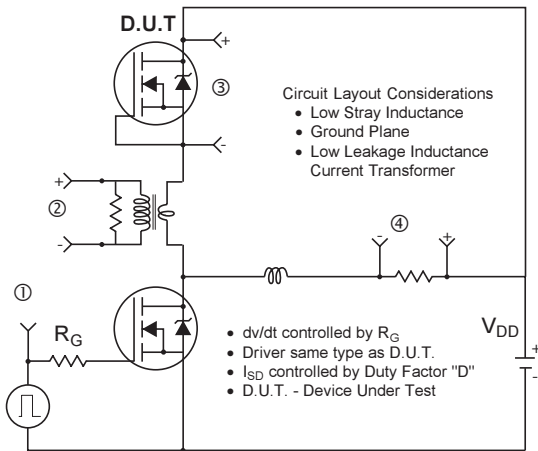


Fig 16b. Gate Charge Waveform



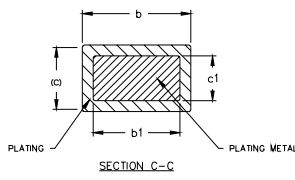
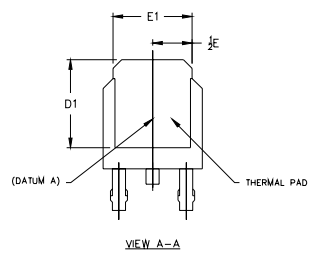
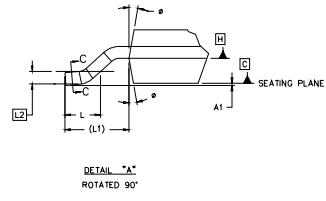
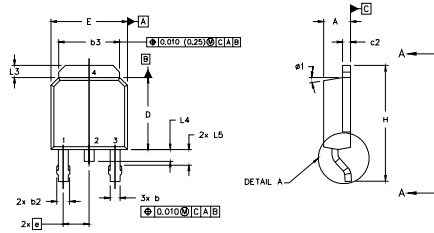
* $V_{GS} = 5V$ for Logic Level Devices

Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

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D-Pak (TO-252AA) Package Outline



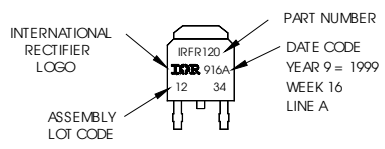
- NOTES:
- 1.0 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
 - 2.0 DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
 - 3.0 LEAD DIMENSION UNCONTROLLED IN L5.
 - 4.0 DIMENSION D1 AND E1 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
 - 5.0 SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 [0.127] AND .010 [0.254] FROM THE LEAD TIP.
 - 6.0 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 - 7.0 OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

| SYMBOL | DIMENSIONS | | | | NOTES |
|--------|-------------|-------|-----------|-------|-------|
| | MILLIMETERS | | INCHES | | |
| | MIN. | MAX. | MIN. | MAX. | |
| A | 2.18 | 2.39 | .086 | .094 | |
| A1 | | 0.15 | | .005 | |
| b | 0.64 | 0.89 | .025 | .035 | 5 |
| b1 | 0.64 | 0.79 | .025 | 0.031 | 5 |
| b2 | 0.76 | 1.14 | .030 | .045 | |
| b3 | 4.95 | 5.46 | .195 | .215 | |
| c | 0.46 | 0.61 | .018 | .024 | 5 |
| c1 | 0.41 | 0.56 | .016 | .022 | 5 |
| c2 | .046 | 0.89 | .018 | .035 | 5 |
| D | 5.97 | 6.22 | .235 | .245 | 6 |
| D1 | 5.21 | - | .205 | - | 4 |
| E | 6.35 | 6.73 | .250 | .265 | 6 |
| E1 | 4.32 | - | .170 | - | 4 |
| e | 2.29 | | .090 BSC | | |
| H | 9.40 | 10.41 | .370 | .410 | |
| L | 1.40 | 1.78 | .055 | .070 | |
| L1 | 2.74 REF. | | .108 REF. | | |
| L2 | 0.093 BSC | | .020 BSC | | |
| L3 | 0.89 | 1.27 | .035 | .050 | |
| L4 | | 1.02 | | .040 | |
| L5 | 1.14 | 1.52 | .045 | .060 | |
| ø | 0" | 10" | 0" | 10" | |
| ø1 | 0" | 15" | 0" | 15" | |

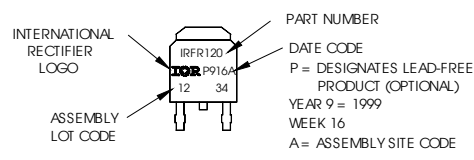
- LEAD ASSIGNMENTS
- HEXFET
- 1.- GATE
 - 2.- DRAIN
 - 3.- SOURCE
 - 4.- DRAIN
- IGBTs, CoPACK
- 1.- GATE
 - 2.- COLLECTOR
 - 3.- EMITTER
 - 4.- COLLECTOR

D-Pak (TO-252AA) Part Marking Information

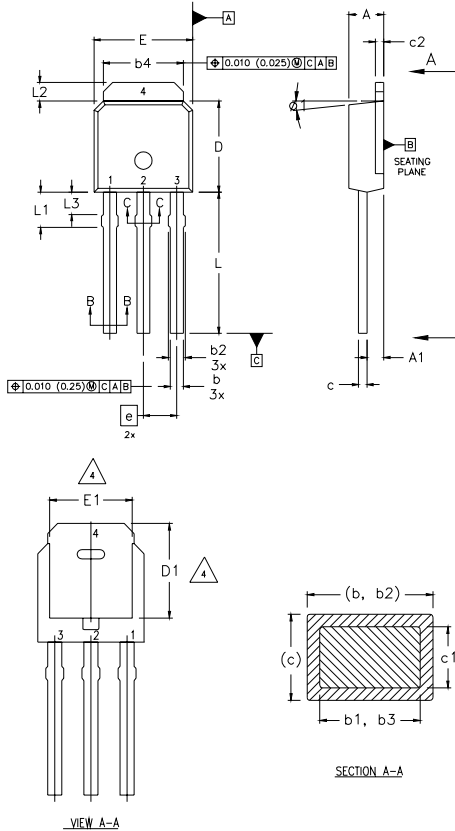
EXAMPLE: THIS IS AN IRFR120 WITH ASSEMBLY LOT CODE 1234 ASSEMBLED ON WW 16, 1999 IN THE ASSEMBLY LINE "A"
Note: "P" in assembly line position indicates "Lead-Free"



OR



I-Pak (TO-251AA) Package Outline



- NOTES:
- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
 - 2 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
 - 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 - 4 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION b4, L2, E1 & D1.
 - 5 LEAD DIMENSION UNCONTROLLED IN L3.
 - 6 DIMENSION b1, b3 APPLY TO BASE METAL ONLY.
 - 7 OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.
 - 8 CONTROLLING DIMENSION : INCHES.

LEAD ASSIGNMENTS

HEXFET

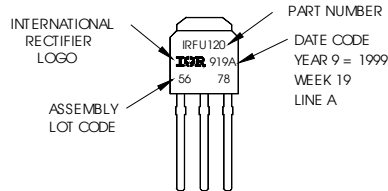
- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

| SYMBOL | DIMENSIONS | | | | NOTES |
|--------|-------------|------|-----------|-------|-------|
| | MILLIMETERS | | INCHES | | |
| | MIN. | MAX. | MIN. | MAX. | |
| A | 2.18 | 2.39 | 0.086 | .094 | |
| A1 | 0.89 | 1.14 | 0.035 | 0.045 | |
| b | 0.64 | 0.89 | 0.025 | 0.035 | |
| b1 | 0.64 | 0.79 | 0.025 | 0.031 | 4 |
| b2 | 0.76 | 1.14 | 0.030 | 0.045 | |
| b3 | 0.76 | 1.04 | 0.030 | 0.041 | |
| b4 | 5.00 | 5.46 | 0.195 | 0.215 | 4 |
| c | 0.46 | 0.61 | 0.018 | 0.024 | |
| c1 | 0.41 | 0.56 | 0.016 | 0.022 | |
| c2 | .046 | 0.86 | 0.018 | 0.035 | |
| D | 5.97 | 6.22 | 0.235 | 0.245 | 3, 4 |
| D1 | 5.21 | - | 0.205 | - | 4 |
| E | 6.35 | 6.73 | 0.250 | 0.265 | 3, 4 |
| E1 | 4.32 | - | 0.170 | - | 4 |
| e | 2.29 | | 0.090 BSC | | |
| L | 8.89 | 9.60 | 0.350 | 0.380 | |
| L1 | 1.91 | 2.29 | 0.075 | 0.090 | |
| L2 | 0.89 | 1.27 | 0.035 | 0.050 | 4 |
| L3 | 1.14 | 1.52 | 0.045 | 0.060 | 5 |
| ø1 | Ø | 15' | Ø | 15' | |

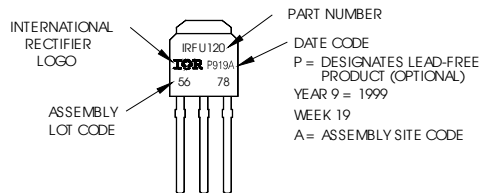
I-Pak (TO-251AA) Part Marking Information

EXAMPLE: THIS IS AN IRFU120
WITH ASSEMBLY
LOT CODE 6678
ASSEMBLED ON WW 19, 1999
IN THE ASSEMBLY LINE "A"

Note: "P" in assembly line position indicates "Lead-Free"



OR

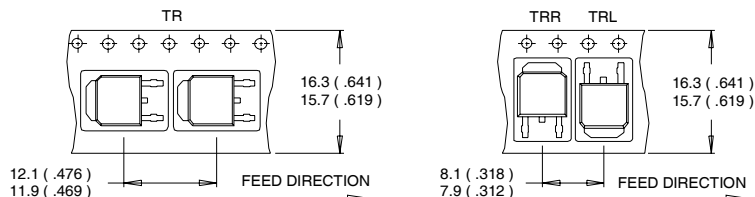


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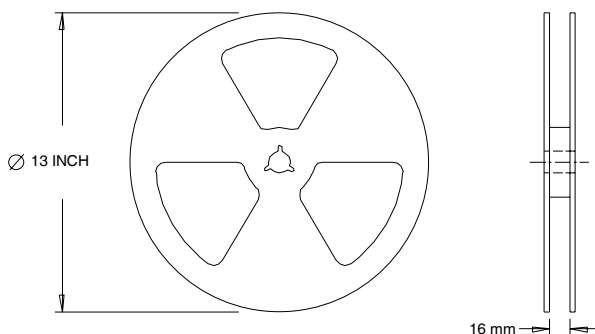
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IR Rectifier

D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES :
1. OUTLINE CONFORMS TO EIA-481.

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^\circ\text{C}$, $L = 0.77\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 17\text{A}$.
- ③ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ④ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 42A.
- ⑤ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- ⑥ R_θ is measured at T_J approximately at 90°C

Data and specifications subject to change without notice.
This product has been designed and qualified for the Industrial market.
Qualification Standards can be found on IR's Web site.

International
IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903

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